

UNISONIC TECHNOLOGIES CO., LTD

UT90N06

Preliminary

90A, 60V N-CHANNEL POWER MOSFET

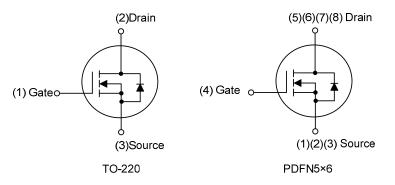
DESCRIPTION

The **UTC UT90N06** is a high voltage and high current power MOSFET, designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.



- * $R_{DS(ON)} \le 6.5 \text{ m}\Omega @ V_{GS}=10V, I_D=45A$
- $R_{DS(ON)} \le 11 \text{ m}\Omega @ V_{GS}=4.5V, I_D=45A$
- * Fast switching
- * 100% avalanche tested
- * Improved dv/dt capability

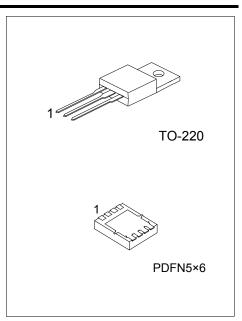
SYMBOL



ORDERING INFORMATION

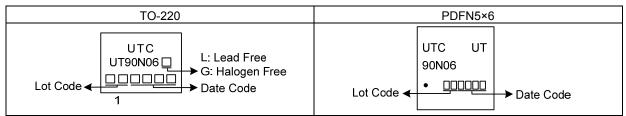
Ordering Number		Dookogo	Pin Assignment						Decking			
Lead Free	Halogen Free	Package	1	2	3	4	5	6	7	8	Packing	
UT90N06L-TA3-T	UT90N06G-TA3-T	TO-220	G	D	S	I	I	-	-	I	Tube	
UT90N06L-P5060-R	UT90N06G-P5060-R	PDFN5×6	S	S	S	G	D	D	D	D	Tape Reel	
Note: Pin Assignment: G: Gate D: Drain S: Source												

UT90N06G-TA3-T		
(2)	Packing Type Package Type Green Package	(1) T: Tube, R: Tape Reel (2) TA3: TO-220, P5060: PDFN5×6 (3) G: Halogen Free and Lead Free, L: Lead Free



UT90N06

MARKING





■ ABSOLUTE MAXIMUM RATING (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	60	V
Gate-Source Voltage		V _{GSS}	±20	V
Drain Current	Continuous	I _D	90	А
	Pulsed (Note 2)	I _{DM}	180	А
Single Pulsed Avalanche E	ingle Pulsed Avalanche Energy (Note 3)		122	mJ
Peak Diode Recovery dv/dt	eak Diode Recovery dv/dt (Note 4)		4.5	V/ns
Power Dissipation	TO-220	D	157	W
	PDFN5×6	P _D	70	W
lunction Temperature		TJ	+150	°C
Storage Temperature Range		T _{STG}	-20 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L= 0.1mH, I_{AS} = 49.4A, V_{DD} = 50V, R_G = 25 $\Omega,$ Starting T_J = 25°C

4. $I_{SD} \le 30A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220	0	62.5	°C/W
	PDFN5×6	θ _{JA}	65 (Note)	°C/W
Junction to Case	TO-220	0	0.79	°C/W
	PDFN5×6	θις	1.78 (Note)	°C/W

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.



■ ELECTRICAL CHARACTERISTICS (T_J =25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	60			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =60V, V _{GS} =0V			1	μA
Gate-Source Leakage Current	orward		V _{GS} =+20V, V _{DS} =0V			+100	nA
	Reverse	I _{GSS}	V _{GS} =-20V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250µA	1.0		3.0	V
Static Drain-Source On-State Resistance			V _{GS} =10V, I _D =45A			6.5	mΩ
		R _{DS(ON)}	V _{GS} =4.5V, I _D =45A			11	mΩ
DYNAMIC PARAMETERS							
Input Capacitance		CISS			3900		рF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		350		рF
Reverse Transfer Capacitance		C _{RSS}			300		рF
SWITCHING PARAMETERS							
Total Gate Charge (Note 1)		Q_{G}			90		nC
Gate to Source Charge		Q_{GS}	V_{DS} =48V, V_{GS} =10V, I_{D} =90A,		8		nC
Gate to Drain Charge		Q_{GD}	I _G =1mA (Note 1, 2)		7		nC
Turn-on Delay Time (Note 1)		t _{D(ON)}			15		ns
Rise Time		t _R	V _{DD} =30V, V _{GS} =10V, I _D =90A,		21		ns
Turn-off Delay Time		t _{D(OFF)}	R _G =3.3Ω (Note 1, 2)		66		ns
Fall-Time		t _F			25		ns
SOURCE- DRAIN DIODE RATINGS	S AND CHA	ARACTERIST	FICS				
Maximum Body-Diode Continuous Current		Is				90	Α
Maximum Body-Diode Pulsed Current		I _{SM}				180	Α
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =90A, V _{GS} =0V			1.4	V
Reverse Recovery Time (Note 1)		t _{rr}	I _S =30A, V _{GS} =0V,		47		nS
Reverse Recovery Charge		Q _{rr}	dI _F /dt =100A/µs		145		nC

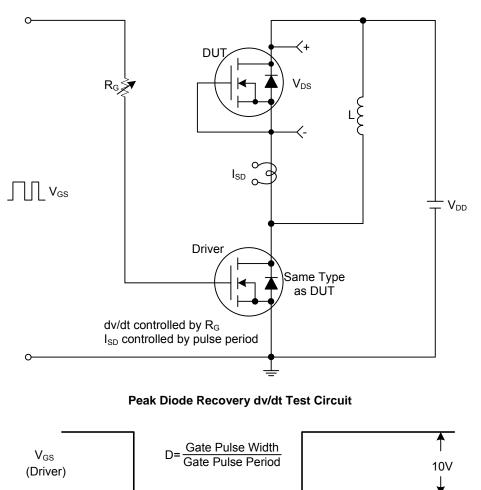
Notes: 1. Pulse Test : Pulse width \leq 300µs, Duty cycle \leq 2%.

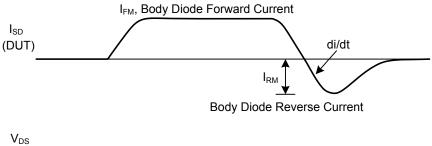
2. Essentially independent of operating ambient temperature.

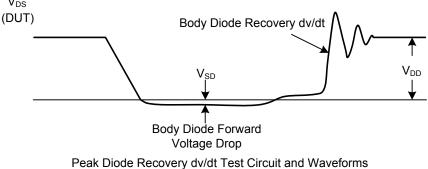


UT90N06

■ TEST CIRCUITS AND WAVEFORMS



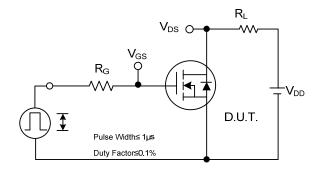


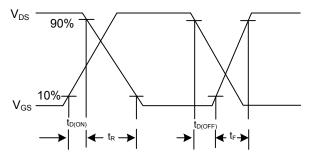


Peak Diode Recovery dv/dt Waveforms



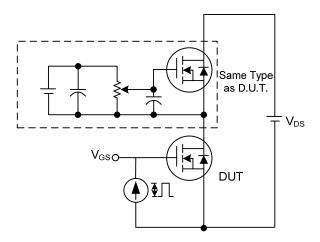
TEST CIRCUITS AND WAVEFORMS



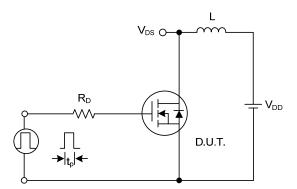




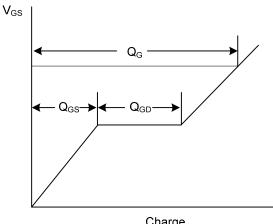




Gate Charge Test Circuit

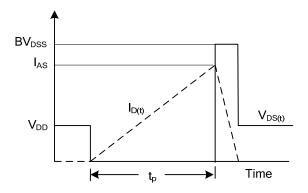


Unclamped Inductive Switching Test Circuit



Charge





Unclamped Inductive Switching Waveforms



UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

